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Test Element Analysis System

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The invention relates to a test element analysis system for the analytical investigation of a sample, in particular a body fluid, of human beings or of animals.

15 The system comprises two components, namely test elements, which are, in order to perform an analysis, brought in contact to a sample to be investigated, and in which a measurable change which is characteristic of the analysis takes place in a measurement zone, as well as an

20 evaluation apparatus comprising a positioning unit for positioning a test element in a measuring position, a measuring unit for measuring the characteristic change, and an electronic evaluation device for obtaining a result of the analysis, based on the result of the

25 measurement.

Test element analysis systems are common in medical science, in particular for the analysis of blood and urine. In most cases, the test elements have the form

of test strips. Other forms of test elements are, however, also common, e.g. flat, essentially square plates.

5           Generally the test elements contain reagents the reaction of which with the sample leads to a detectable change of the test element; this change is measured with the evaluation apparatus belonging to the system. Very common are photometric analysis systems, in which the  
10 reaction causes a color change in a detection layer of the test element. The color change is then measured photometrically. Electrochemical analysis systems are also of important significance. In these, an electrically measurable change of the test element occurs due to the  
15 reaction. Apart from these analysis systems working with reagents, reagent-free analysis systems are discussed, too. In these, an analytically characteristic property (e.g. the light absorption spectrum) of the sample itself is measured after contacting the test element with the  
20 sample. The invention is generally suitable in combination with all these procedures.

Test element analysis systems are used in medical laboratories. The invention is, however, particularly  
25 intended for applications in which the patients themselves perform the analysis in order to monitor their health state (home monitoring). This is of particular medical importance for diabetics, who have to check the glucose concentration in their blood several times a day

in order to adjust the insulin injections. For such applications, the evaluation apparatuses must be light-weight, small, battery-operated, inexpensive and robust.

5           A fundamental problem is due to the fact that the measured quantity which is characteristic for the analysis, is in many cases very temperature-dependent. This temperature dependence is, in many cases, about one or two percent per degree. In home-monitoring, the exposure of the analysis system to high temperature changes is unavoidable. Temperature variations of at least  $\pm 5^\circ$  have to be taken into account. Much higher temperature variations may occur, if measurements are to be performed under unusual conditions (e.g. in a car or outdoors).

10           In order to avoid the measurement uncertainties resulting from this, it was proposed to control the temperature of the measuring zone of the test element to a constant value by means of a corresponding constant-temperature unit. For example, US patent 5,035,862 describes temperature control of individual test fields of urine test strips by means of inductive heating. However, such procedures are, due to their high energy consumption, not practicable for small battery-operated apparatuses.

25           Some analysis systems use a temperature measurement in order to allow a correction of measurement

errors caused by temperature variations. This is commonly achieved by an electrical temperature sensor (e.g. a thermocouple or a thermal resistor). Due to design limitations of commonly used analysis systems, the temperature sensor is located at a place remote from the measuring zone of the test element. It is, therefore thermally separated from the measuring zone, i.e. it is not thermally coupled with the measuring zone, in such a manner that the measured momentary temperature coincides at any time with the actual temperature of the measuring zone. Such a temperature sensor is hereafter called Ambient Temperature Sensor (ATS).

The electronic evaluation device of such systems includes a temperature correction unit, which is adapted to take into account the temperature prevailing at the point of time when the measurement for the determination of the result of the analysis is made. Such a correction requires, however, the coincidence of the actual temperature in the measuring zone of the analysis element with the momentary temperature measured by the ATS at the time of measuring. This condition is not always given, in particular in home-monitoring systems as the live circumstances of the patient require analyses to be performed at different places and with changing temperature conditions. These temperature variations can cause large deviations of the momentary temperature measured by the ATS as compared to the actual temperature in the measuring zone of the test element.

It is an object of the invention to provide an analysis system which allows an increased measurement accuracy by an improved temperature compensation. This shall be achieved in a way which complies with the requirements of home-monitoring systems. In particular, this improvement shall not lead to a significant increase of the weight, the size or the battery consumption of the evaluation apparatus.

the temperature correction unit includes a temperature history imaging device, which traces the temperature history preceding the time of the measurement in a currentless manner, i.e. without using electric energy up to the time of measurement.

The temperature history imaging device allows to take into account, in the evaluation of the measurement signal and calculation of the result of the analysis, the temperature history in the vicinity of the apparatus before the point of time in which the measurement is made. This provides a substantially improved information about the actual temperature in the area of the measurement zone of the test element. If, for example, the evaluation apparatus was brought from a cold ambient (e.g. a car parked outdoors at a temperature of 10°C) into a considerably warmer ambient (e.g. a living room with a temperature of 20°C), this large temperature increase is indicated by the temperature history imaging device. In this case, it must be assumed that the momentary temperature indicated by an ATS does not correspond to the actual ambient temperature (thus, there is no thermal equilibrium to the ambient). The temperature in the measuring zone of the test element follows ambient temperature changes much faster than an ATS fixed in the apparatus housing, because the heat transfer from the ambient to the test zone is relatively good and the heat capacity of the test element is relatively small. The corresponding delay of the

momentary temperature measured in the apparatus as compared to the actual temperature of the measurement zone, can be estimated using the output of the temperature history imaging device and corresponding empirical vales, programmed into the electronic evaluation device. On the basis of this information, the result of the analysis can be corrected, or - if a correction is not possible due to excessive temperature changes - the calculation of the result of the analysis can be interrupted, outputting an error signal.

An essential characteristic of the invention is the fact that no electric energy is consumed during the period to which the temperature history refers. A temperature history imaging device which operates in this sense "currentless" can be provided at very low cost. Hereafter it will be called System Temperature History Device (STHD).

The system of the invention is, in particular, better appropriate for the home-monitoring analysis than a system described in US patent 5,405,511, which measures the temperature electrically by an ATS in regular intervals and determines on the basis of the sequence of measured temperatures a corrected temperature by extrapolation. This requires to make temperature measurements for a sufficiently long period before the analysis, either continuously or in predetermined intervals. In order to avoid a waiting time before the

performance of a test, temperature measurements are also performed, in intervals of several minutes, when the apparatus is switched off. This allows to perform the extrapolation to the correction temperature immediately  
5 after switching on the apparatus. The drawback, however, is an increased battery consumption, as the electronic system of the apparatus must be repeatedly operated in intervals of only a few minutes in order to determine the temperature.

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The STHD can be embodied in different ways. For example, a temperature-sensitive liquid crystal chip, being in thermal contact to a bigger thermal mass (e.g. glued onto a metal body) may be used. In this case the  
15 imaging of the temperature history is based on the fact that changes of the ambient temperature lead in different zones of the chip to different rates of the color change of the liquid crystals. These color changes can be photometrically measured.

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Another embodiment is, however, simpler and therefore preferable, in which the STHD includes a thermal mass and a plurality of electric temperature sensors which are located in different places. At least  
25 one temperature sensor designated as Temperature History Sensor (THS) is located inside the thermal mass. The thermal mass is formed by a solid body with a high and constant heat capacity. It is heat-insulated in the evaluation apparatus, i.e. as completely as possible



thermally insulated from all other constructive elements of the device, so that its temperature depends, as far as possible, only on the heat exchange with the ambient air taking place at the surface of the thermal mass.

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According to a preferred design, a temperature sensor belonging to the STHD, hereafter designated as Reference Temperature Sensor (RTS), is located near the thermal mass - but without direct contact to it - in a way that it measures the temperature of the ambient air in the vicinity of the thermal mass. This temperature sensor can simultaneously serve as ATS of the temperature correction device. In this embodiment, the function of the STHD is based on the comparison of the temperature measured inside the thermal mass with the temperature of the ambient air in its vicinity. If both temperature values coincide, it can be assumed that the ambient temperature has not changed in the period preceding the measurement. If the temperature of the thermal mass is smaller than the ambient temperature, it can be assumed that the temperature rose before the time of measurement. In the opposite case (thermal mass warmer than ambient temperature) the temperature has fallen.

For this embodiment, the material of the thermal mass is preferably chosen such that the heat transfer inside the thermal mass which is determined by the thermal conductivity of its material, is fast, compared to the heat transfer between the ambient temperature and

the thermal mass. For the majority of typical solid materials, in particular for metals, but also for plastics, this condition is complied with, as the thermal conductivity of these materials is high in comparison to the heat exchange with the ambient air taking place at their surface. Therefore, most solids are isothermal heat storage elements. A significant temperature gradient can only be established at the surface of such solid materials, whereas internal temperature gradients in the bulk of such materials are so small that they can only be measured with very sophisticated equipment.

It is, however, also possible to make the thermal mass from a material having a thermal conductivity which is so small that changes of the ambient temperature lead to temperature gradients in the interior of the thermal mass which can be measured with sufficient accuracy at tolerable technological expense. Materials which comply with this condition, and which have, at the same time, a sufficiently high thermal capacity, are e.g. highly porous insulator materials, for example porous glass or ceramic materials. If such a material is used for the thermal mass, preferably at least two temperature sensors of the STHD are in contact with the thermal mass. The difference of the temperature outputs of these temperature sensors is an indication of the change of the ambient temperature before the time of measurement. With other words: For such a STHD, the spatial temperature gradient in the thermal mass, resulting from the change

in time of the ambient temperature, provides an information about the temporal temperature history before the point in time at which the measurement is made. To this end it is favorable to locate one of the temperature  
5 sensors in the vicinity to the boundary layer of the thermal mass in contact with the ambient air. This sensor is designated as Mass Boundary Layer Sensor (MBLS). The second sensor (THS) should be located as far away as possible from this boundary layer, in the bulk of the  
10 thermal mass.

The invention is subsequently described in more detail with reference to embodiments shown in the figures. The described features can be used individually  
15 or in combination in order to create preferred embodiments of the invention.

Fig. 1 shows a partial sectional view of an analysis system according to the invention;

20 Fig. 2 shows a perspective view of a STHD appropriate for the invention;

Fig. 3 shows a partial sectional view of the STHD according to figure 2;

Fig. 4 shows a graphical representation of the  
25 temporal change of the measured value of a THS in the interior of a thermal mass for an embodiment according to figures 2 and 3;

Fig. 5 shows a partial sectional view of an alternative design of a STHD;

Fig. 6 shows a schematic representation of an alternative shape of a thermal mass.

The analysis system shown in figure 1 consists of  
5 an evaluation apparatus 2 and of single use (disposable)  
test elements 3.

The evaluation apparatus 2 has a test element  
support 5 for fixing a test element 3 in the measuring  
10 position shown in figure 1. The test element 3 is fixed  
in the measuring position by appropriate means, as e.g. a  
leaf spring 6.

For performing a measurement, sample liquid is  
15 transported to a measurement zone 7 of the test element  
3. In the embodiment shown, this is accomplished by  
contacting a blood drop 8 to a sample application zone 9,  
located at an end of the test element 3, from which it is  
suctioned to the measurement zone 7 through a capillary  
20 gap 10. A reagent layer 12, which is dissolved by the  
sample liquid and reacts with its components, is located  
in the measurement zone 7.

The reaction leads to a measurable change in the  
25 measurement zone 7. In the represented case of an  
electrochemical test element, the measurement of an  
electrical quantity is performed by means of electrodes  
located in the measurement zone, not shown in the figure.  
In the measuring position, a contact is made between the

electrodes of the test element 3 and terminal contacts 14 of the test element support 5. The terminal contacts 14 are connected to a measuring and evaluation electronic device 15, highly integrated for compact design and high reliability. In the represented case, the electronic device consists mainly of a printed circuit board 16 and a special IC (ASIC) 17. So far, the analysis system shown is conventional and does not require further explanation.

A component of the electronic measuring and evaluation device 15 is a temperature correction unit 18 comprising a temperature history imaging device STHD 20, shown in more detail in figures 2 and 3. It consists essentially of a spherical thermal mass 22 suspended in a heat insulated manner, a first temperature sensor (THS) 23 located in the center of the thermal mass 22, and a second temperature sensor (RTS) 24, located in the vicinity of the thermal mass 22, but without contact to the thermal mass 22. This RTS is, simultaneously, the ATS of the temperature correction unit. This STHD is an example of the above explained first type, in which the thermal conductivity of the thermal mass 22 is sufficiently high that it forms an isothermal heat storage element. Therefore, the first temperature sensor (THS) can be located at an almost randomly chosen point in the interior of the thermal mass 22. With this design type, the outer shape of the thermal mass 22 is of minor significance for its function.

It is, however, important that the thermal mass 22 is fixed in such a manner that its temperature essentially only depends from the temperature of the ambient air, and that an economic inexpensive production is possible. To this end the thermal mass 22 is in the embodiment shown integrated into a printed circuit board 16; preferably a common printed circuit board 16 is used for the measurement and evaluation electronic device as well as for the STHD. The printed circuit board 16 has recesses 26 located in the vicinity of the thermal mass 26, designed in a way that the thermal mass is touched and supported by only relatively thin fingers 27. Thereby the heat transfer from the printed circuit board 16 to the thermal mass 22 is minimized. The first temperature sensor 23 is located in a bore 29 of the thermal mass 22, which after insertion of the temperature sensor is filled up with cast resin.

The second temperature sensor 24 is freely suspended at its wires in one of the recesses 26. Both sensors 23,24 are connected via contact points 31, to conductor tracks (not shown) of the printed circuit board 16.

In a practical embodiment, the thermal mass 23 was formed by an aluminum ball having a diameter of 6 mm and being fixed in a printed circuit board made of plastic of 0.8 mm thickness, as represented in the figure. Thermistors with a diameter of 0.25 mm and with

conductor wires of a thickness of 0.025 mm were used as temperature sensors.

The thermal response of such a system, in case of  
5 a sudden temperature change from 18°C to 22°C, is  
represented in figure 4. The abscissa shows the time in  
seconds and the ordinate shows the temperature in degree  
C. It becomes apparent that the temperature change  
occurring within three minutes is easily measurable.  
10 Thus, the comparison between the temperatures measured  
with the THS 23 and the RTS 24 allows valid conclusions  
with respect to temperature changes in the past. By  
choosing the size of the thermal mass the rate of  
temperature change of the STHD can be adjusted in a way  
15 that it corresponds to the measuring situation of the  
analysis apparatus. The time constant of the temperature  
change of the STHD should approximately correspond to the  
time constant of the delay of the temperature change of  
the ATS with respect to the temperature of the  
20 measurement zone.

For the embodiment shown, a single temperature  
sensor 24 forms, on the one hand, the ATS of the  
temperature correction unit, and, on the other hand, the  
25 RTS of the STHD. This is cost-effective and, thus,  
favorable. In principle, it is, however, possible to  
supply an ATS in another location of the apparatus,  
independent from the STHD.

Figure 5 shows an embodiment of the STHD which corresponds to the above mentioned second type, the thermal mass of the STHD of which has a very low thermal conductivity, and, at the same time, a sufficiently high  
5 heat capacity.

For this embodiment it is important that the THS 23, fixed in the interior of the thermal mass, is positioned in such a manner that the distance between the  
10 sensor and all points of the boundary surface of the thermal mass 32, which are not isolated from the ambient air, is essentially the same. In the represented case, in which the thermal mass is spherical and is in thermal contact with ambient air with almost its entire surface,  
15 this means that the THS should be located in the center of the thermal mass.

Here, a MBLS 24 is arranged at the surface of the thermal mass 32. Temperature variations in the ambient of  
20 such a STHD lead to the formation of spatial temperature gradients in the interior of the thermal mass 32; these are registered with two or more temperature sensors distributed in or at the thermal mass, enabling a very detailed tracing of the temperature history preceding the  
25 point of time at which the measurement is made, without consuming electric energy in the time before the measurement.



The mentioned condition to keep a uniform distance between the THS 23 and the points on the surface which are not thermally insulated, can be fulfilled in different ways. For example, figure 6 shows a schematic  
5 sketch of a design in which the thermal mass is shaped as a disk; the flat sides of the disks are thermally insulated from the ambient air by insulating elements 34, and the THS is located in the center of the disk.

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